

### ES51C1 A 10 N -10.000M

Series

ROHS Compliant (Pb-free) 5mm x 7mm Ceramic SMD

5.0Vdc Clipped Sinewave TC(VC)XO

Operating Temperature Range

0°C to +50°C

Control Voltage None (No Connect on Pin 1)

Nominal Frequency 10.000MHz

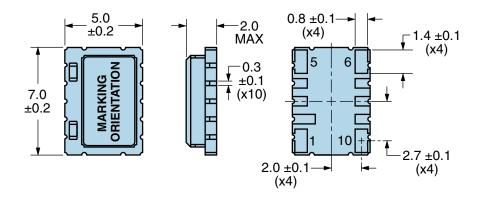
Frequency Stability ±1.0ppm Maximum

| ELECTRICAL SPECIFICATIONS                   |   |  |
|---|---|--|
| Nominal Frequency                           | 10.000MHz   |  |
| Frequency Stability vs. Frequency Tolerance | ±1.0ppm Maximum (Measured at 25°C ±2°C, Vdd=5.0Vdc, Vc=1.5Vdc)  |  |
| Frequency Stability                         | ±1.0ppm Maximum   |  |
| Frequency Stability vs. Input Voltage       | ±0.2ppm Maximum (Vdd ±5%)   |  |
| Frequency Stability vs. Aging               | ±1ppm/Year Maximum (at 25°C)  |  |
| Frequency Stability vs. Load                | ±0.2ppm Maximum (±1kOhm//±1pF)  |  |
| Operating Temperature Range                 | 0°C to +50°C  |  |
| Supply Voltage                              | 5.0Vdc ±5%  |  |
| Input Current                               | 1.5mA Maximum   |  |
| Output Voltage                              | 0.8Vp-p Clipped Sinewave Minimum  |  |
| Load Drive Capability                       | 10kOhms//10pF   |  |
| Output Logic Type                           | Clipped Sinewave  |  |
| Control Voltage                             | None (No Connect on Pin 1)  |  |
| Phase Noise                                 | -80dBc/Hz at 10Hz offset, -115dBc/Hz at 100Hz offset, -135dBc/Hz at 1kHz offset, -145dBc/Hz at 10kHz offset, -145dBc/Hz at 100kHz offset (Typical Values, at 12.800MHz) |  |
| Start Up Time                               | 5mSec Maximum   |  |
| Storage Temperature Range                   | -55°C to +125°C   |  |

| ENVIRONMENTAL & MECHANICAL SPECIFICATIONS |                                      |  |
|---|--------------------------------------|--|
| Fine Leak Test                            | MIL-STD-883, Method 1014 Condition A |  |
| Gross Leak Test                           | MIL-STD-883, Method 1014 Condition C |  |
| Mechanical Shock                          | MIL-STD-202, Method 213 Condition C  |  |
| Resistance to Soldering Heat              | MIL-STD-202, Method 210              |  |
| Resistance to Solvents                    | MIL-STD-202, Method 215              |  |
| Solderability                             | MIL-STD-883, Method 2003             |  |
| Temperature Cycling                       | MIL-STD-883, Method 1010             |  |
| Vibration                                 | MIL-STD-883, Method 2007 Condition A |  |



### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**

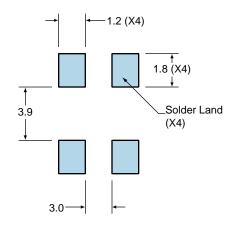


| PIN | CONNECTION     |
|-----|----------------|
| 1   | No Connect     |
| 2   | Do Not Connect |
| 3   | Do Not Connect |
| 4   | Do Not Connect |
| 5   | Case/Ground    |
| 6   | Output         |
| 7   | Do Not Connect |
| 8   | Do Not Connect |
| 9   | Do Not Connect |
| 10  | Supply Voltage |

| LINE | MARKING  |
|------|--|
| 1    | E10.000<br>E=Ecliptek  |
| 2    | XXYZZ  XX=Ecliptek Manufacturing Code  Y=Last Digit of the Year  ZZ=Week of the Year |

#### **Suggested Solder Pad Layout**

All Dimensions in Millimeters

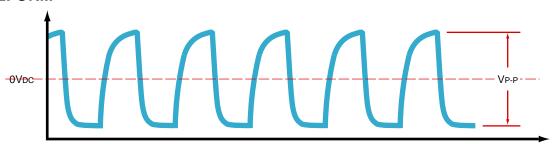


All Tolerances are ±0.1

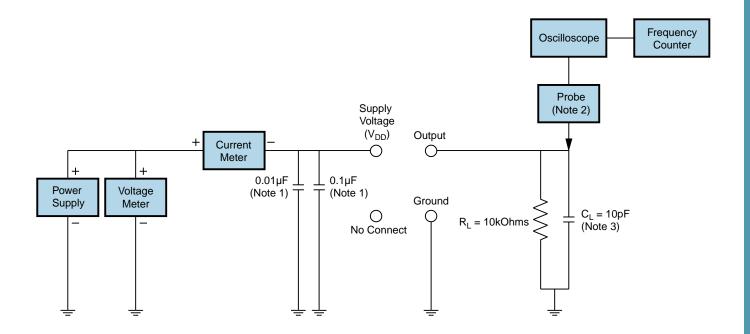


### **OUTPUT WAVEFORM**

**CLOCK OUTPUT** 



#### **Test Circuit for No Connect Option**



- Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value C<sub>L</sub> includes sum of all probe and fixture capacitance.



### **Recommended Solder Reflow Methods**



#### Low Temperature Infrared/Convection 220°C

| T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 5°C/second Maximum                                    |
|---|---|
| Preheat   |   |
| - Temperature Minimum (T <sub>s</sub> MIN)          | N/A   |
| - Temperature Typical (T <sub>S</sub> TYP)          | 150°C   |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A   |
| - Time (t <sub>s</sub> MIN)                         | 60 - 120 Seconds                                      |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 5°C/second Maximum                                    |
| Time Maintained Above:                              |   |
| - Temperature (T∟)                                  | 150°C   |
| - Time (t∟)   | 200 Seconds Maximum                                   |
| Peak Temperature (T <sub>P</sub> )                  | 220°C Maximum   |
| Target Peak Temperature (T <sub>P</sub> Target)     | 220°C Maximum 1 Time / 215°C Maximum 1 Time           |
| Time within 5°C of actual peak (tp)                 | 15 seconds Maximum 1 Time / 80 seconds Maximum 1 Time |
| Ramp-down Rate                                      | 5°C/second Maximum                                    |
| Time 25°C to Peak Temperature (t)                   | N/A   |
| Moisture Sensitivity Level                          | Level 1   |

#### **Low Temperature Manual Soldering**

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.